

# MOS FIELD EFFECT TRANSISTOR

2SK2111

# N-CHANNEL MOS FET FOR HIGH-SPEED SWITCHING

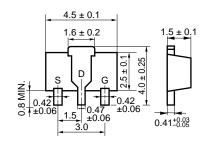
The 2SK2111 is a N-channel MOS FET of a vertical type and is a switching element that can be directly driven by the output of an IC operating at  $5\ V$ .

This product has a low ON resistance and superb switching characteristics and is ideal for driving the actuators, such as motors and DC/DC converters.

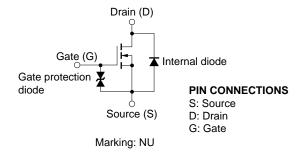
#### **FEATURES**

- Low ON resistance  $R_{DS(on)} = 0.6~\Omega~MAX.~@V_{GS} = 4.0~V,~I_{D} = 0.5~A$
- High switching speed ton + toff < 100 ns</li>
- · Low parasitic capacitance

#### PACKAGE DIMENSIONS (in mm)



#### **EQUIVALENT CIRCUIT**



#### ABSOLUTE MAXIMUM RATINGS $(T_A = 25 \degree C)$

PARAMETER	SYMBOL	TEST CONDITIONS	RATING	UNIT
Drain to Source Voltage	VDSS	Vgs = 0	60	V
Gate to Source Voltage	Vgss	V <sub>DS</sub> = 0	±20	V
Drain Current (DC)	I <sub>D(DC)</sub>		±1.0	Α
Drain Current (Pulse)	D(pulse)	PW ≤ 10 ms, Duty cycle ≤ 50 %	±2.0	А
Total Power Dissipation	Рт	16 cm $^2 \times$ 0.7 mm, ceramic substrate used	2.0	W
Channel Temperature	Tch		150	°C
Storage Temperature	T <sub>stg</sub>		-55 to +150	°C

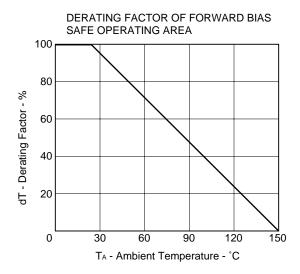


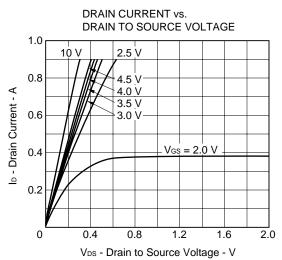
# ELECTRICAL CHARACTERISTICS (TA = 25 °C)

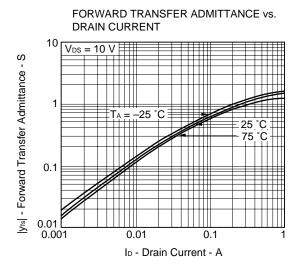
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-Off Current	IDSS	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0			1.0	μΑ
Gate Leakage Current	Igss	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$			±10	μΑ
Gate Cut-Off Voltage	V <sub>GS(off)</sub>	V <sub>D</sub> S = 10 V, I <sub>D</sub> = 1 mA	0.8	1.4	2.0	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.5 A	0.4			S
Drain to Source On-State Resistance	RDS(on)1	Vgs = 4.0 V, ID =0.5 A		0.32	0.6	Ω
Drain to Source On-State Resistance	R <sub>DS(on)2</sub>	Vgs = 10 V, ID = 0.5 A		0.24	0.45	Ω
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0, f = 1.0 MHz		170		pF
Output Capacitance	Coss			87		pF
Reverse Transfer Capacitance	Crss			32		pF
Turn-On Delay Time	td(on)	V <sub>DD</sub> = 25 V, I <sub>D</sub> = 0.5 A		2.8		ns
Rise Time	tr	$V_{GS(on)}$ = 10 V, Rg = 10 $\Omega$		2.3		ns
Turn-Off Delay Time	td(off)	R <sub>L</sub> = 50 Ω		55		ns
Fall Time	t <sub>f</sub>			27		ns

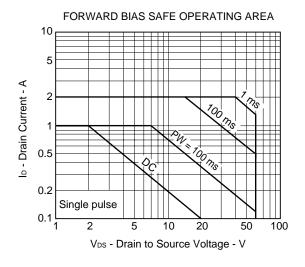
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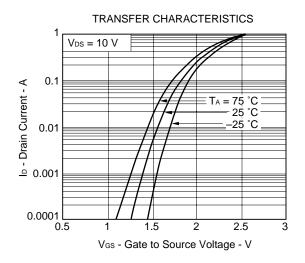
#### TYPICAL CHARACTERISTICS (TA = 25 °C)

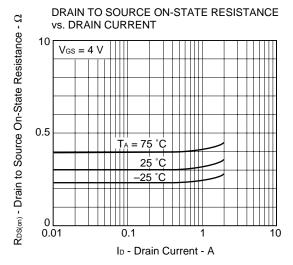




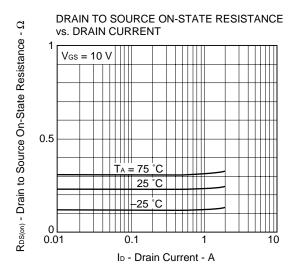


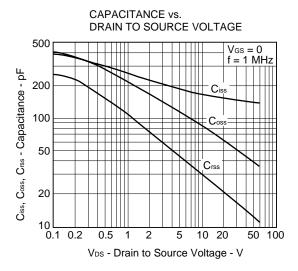


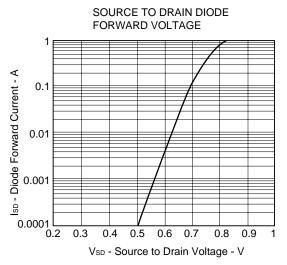


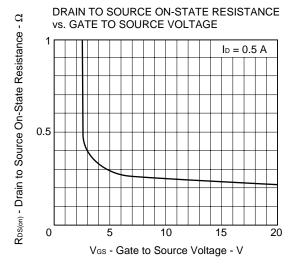


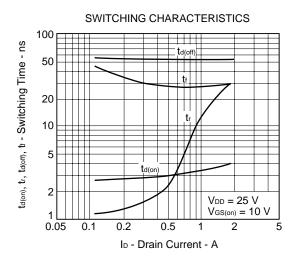














# REFERENCE

Document Name	Document No.		
NEC semiconductor device reliability/quality control system	TEI-1202		
Quality grade on NEC semiconductor devices	IEI-1209		
Semiconductor device mounting technology manual	C10535E		
Guide to quality assurance for semiconductor devices	MEI-1202		
Semiconductor selection guide	X10679E		

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Anti-radioactive design is not implemented in this product.

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